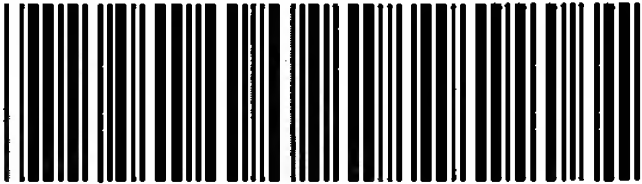


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/620,705	NAKADA, MASATO	
	Examiner	Art Unit	
	Helen Nguyen	3736	

SEARCHED			
Class	Subclass	Date	Examiner
Updated		5/26/2006	HQN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Updated		5/26/2006	HQN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated	5/26/2006	HQN